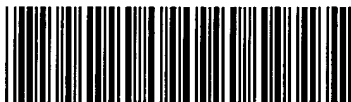


Search Notes

Application/Control No.

10/529,547

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

HONKURA ET AL.

Art Unit

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SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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